Please add new claims 14-31 as follows:

--14. (New) A magnetic resonance imaging apparatus comprising:

a static magnetic field generating unit for generating a homogeneous static magnetic filed in an inspection space;

a gradient magnetic field generating unit for generating a magnetic field strength gradient;

a high frequency magnetic field generating unit;

a detecting unit for detecting nuclear magnetic resonance signals generated from an object to be examined;

a display unit for displaying an image as an result based on the detection;

a temperature detecting unit for detecting a temperature of said static magnetic field generating unit and/or surroundings thereof;

a magnetic field correcting unit for generating an additional magnetic field for correcting non-uniformity of said static magnetic field being caused by temperature change of said static magnetic field generating unit and/or surrounding space of it; and

a control unit for controlling said magnetic field correcting unit based on the temperature detected by said temperature detecting unit.

- 15. (New) A magnetic resonance imaging apparatus according to claim 14, wherein the control unit has a temperature setting unit that sets a temperature detected by the temperature-detecting unit.
  - 16. (New) A magnetic resonance imaging apparatus according to claim 14, wherein the temperature detecting unit detects temperatures of at least two positions.
- 17. (New) A magnetic resonance imaging apparatus according to claim 14, wherein the magnetic field correcting unit comprises a shim coil for generating an additional magnetic field and a shim power source that supplies a current to the shim coil.
  - 18. (New) A magnetic resonance imaging apparatus according to claim 14,

wherein the control unit comprises a voltage generating unit that generates a voltage corresponding to a non-uniformity component of the magnetic field at the temperature detected by the temperature detecting unit, a voltage/current converter that converts the voltage output by the voltage generating unit to current, and a supplying unit that supplies to the magnetic field correcting unit the current generated from the voltage/current converter.

19. (New) A magnetic resonance imaging apparatus according to claim 14, wherein the magnetic field correcting unit generates at least one additional magnetic field of linear term of y, quadratic term of z and quartic term of z, where z is the direction of the static magnetic field and y is one direction orthogonal to z.

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- 20. (New) A magnetic resonance imaging apparatus according to claim 14, wherein the temperature detecting unit is disposed near the static magnetic field generating unit and/or in a room where the static magnetic field generating unit is placed.
- 21. (New) A method for maintaining uniformity of a static magnetic field generated by a static magnetic field generating unit in a magnetic resonance imaging apparatus, by generating an additional magnetic field, the method comprising the steps of:

calculating a temperature dependence of non-uniformity of the static magnetic field in an inspection space for an object to be examined, said non-uniformity distribution of the static magnetic field being caused by temperature change of the static magnetic field generating unit and/or surroundings thereof; and

detecting a temperature of the static magnetic field generating unit and/or surroundings thereof; and

generating the additional magnetic field having a magnetic field distribution for correcting said nonuniformity of the static magnetic field based on the detected temperature.

22. (New) A magnetic resonance imaging apparatus comprising:
a static magnetic field generating means for generating a homogeneous static
magnetic field in an inspection space; and

an uniformity correcting means for detecting temperature change affecting the uniformity of the static magnetic field generated by the static magnetic field generating means

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and for generating an additional static magnetic field for canceling non-uniformity of the static magnetic field based on the detected temperature change.

23. (New) A magnetic resonance imaging apparatus comprising:

a static magnetic field generating unit for generating a static magnetic filed of a predetermined intensity, said static magnetic field generating unit comprising a pair of superconducting coils and a pair of cryostats each accommodating one of said pair of superconducting coils;

a supporting means for supporting said pair of cryostats as being apart so as to form an inspection space for an object to be examined;

a gradient magnetic field generating unit for generating a magnetic field having an intensity gradient;

means for generating a high frequency magnetic field;

means for detecting nuclear magnetic resonance signals generated from said object; means for processing said nuclear magnetic resonance signals and for displaying the processed results;

a temperature detecting unit for detecting a temperature of said static magnetic field generating unit and/or surroundings thereof;

a magnetic field correcting unit for generating an additional magnetic field for correcting non-uniformity of said static magnetic field being caused by temperature change of said static magnetic field generating unit and/or surrounding space of it; and

a control unit for controlling said magnetic field correction unit based on the temperature detected by said temperature detecting unit.

- 24. (New) A magnetic resonance imaging apparatus according to claim 23, wherein the control unit has a temperature setting unit that sets a temperature detected by the temperature-detecting unit.
  - 25. (New) A magnetic resonance imaging apparatus according to claim 23, wherein the temperature detecting unit detects temperatures of at least two positions.
    - 26. (New) A magnetic resonance imaging apparatus according to claim 23,

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wherein the magnetic field correcting unit comprises a shim coil for generating an additional magnetic field and a shim power source that supplies a current to the shim coil.

27. (New) A magnetic resonance imaging apparatus according to claim 23, wherein the control unit comprises a voltage generating unit that generates a voltage corresponding to a non-uniformity component of the magnetic field at the temperature detected by the temperature detecting unit, a voltage/current converter that converts the voltage output by the voltage generating unit to current, and a supplying unit that supplies to the magnetic field correcting unit the current generated from the voltage/current converter.

- 28. (New) A magnetic resonance imaging apparatus according to claim 23, wherein the magnetic field correcting unit generates at least one additional magnetic field of linear term of y, quadratic term of z and quartic term of z, where z is the direction of the static magnetic field and y is one direction orthogonal to z.
- 29. (New) A magnetic resonance imaging apparatus according to claim 23, wherein the temperature detecting unit is disposed near the static magnetic field generating unit and/or in a room where the static magnetic field generating unit is placed.
- 30. (New) A magnetic resonance imaging apparatus comprising:
  a static magnetic field generating unit for generating a static magnetic filed of a
  predetermined intensity, said static magnetic field generating unit including a pair of
  superconducting coils;
- a supporting means for supporting said pair of superconducting coils as being apart so as to form an inspection space for an object to be examined;
- a gradient magnetic field generating means for generating a magnetic field having an intensity gradient;

means for generating a high frequency magnetic field;

means for detecting nuclear magnetic resonance signals generated from said object; means for processing said nuclear magnetic resonance signals and for displaying the processed results;

a temperature detecting unit for detecting a temperature of said static magnetic field generating unit and/or surroundings thereof;

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a magnetic field correcting unit for generating an additional magnetic field for correcting non-uniformity of said static magnetic field being caused by deformation of said supporting means due to the temperature change of said static magnetic field generating unit and/or surrounding space of it; and

a control unit for controlling said magnetic field correction unit based on the temperature detected by said temperature detecting unit.

31. (New) A magnetic resonance imaging apparatus according to any one of claims 1, 13, 14, 23 and 30;

wherein said apparatus further comprises means for calculating a temperature dependence of non-uniformity of the static magnetic field in the inspection space, said non-uniformity distribution of the static magnetic field being caused by temperature change of the static magnetic field generating unit and/or surroundings thereof;

means for holding a control data for correcting the non-uniformity of the static magnetic filed corresponding to the temperature; and

means for outputting the control data being selected from said control data holding means based on the detected temperature into said control unit.--

## **REMARKS**

Claims 1-13 are rejected. The specification and claims 5 and 8 are herein amended to clarify the inventive concept using more proper wording. Namely, the terms "ununiform" and "ununiformity" have been replaced by "non-uniform" and "non-uniformity", respectively, throughout the specification. New claims 14-31 are herein added. Independent claims 14, 22, 23 and 30 are of variations in scope of claim 1 and dependent claims 15-20 and 24-29 correspond to dependent claims 2-7, respectively. Claim 21 is of a variation in scope corresponding to claims 8 and 9. No new matter has been introduced.

Claims 1-31 are in the case.

## Claim for Foreign Priority under 37 C.F.R. § 1.55:

In the Office Action dated April 24, 2002, Claims 1-13 are rejected under 35 U.S.C. § 102(e) as allegedly anticipated by *Watkins et al.* (U.S. Patent 6,252,405 B1; "Watkins") which was filed November 15, 1999 and issued June 26, 2001. The filing date of Watkins falls between the foreign priority dates claimed by the Applicant for the present